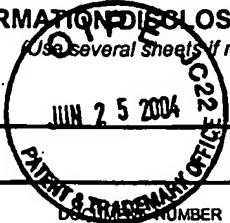


INFORMATION DISCLOSURE CITATION <small>(Use several sheets if necessary)</small>				ATTY DOCKET NO.		APPLICATION NO.	
				04558/085001		10/810,505	
				APPLICANT(S) Eri Kojima, et al.			
				FILING DATE		GROUP ART UNIT	
				03/26/2004		1745	



U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
/RA/	A1	US 2002/0177044 A1	11/28/2002	Yagi, et al.	429	231.95	04/11/2002

U.S. PATENT APPLICATION PUBLICATIONS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS								
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
/RA/	B1	2001-256968	09/21/2001	Japan	H01M	4/02		✓

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)			
/RA/	C1	Patent Abstracts of Japan, publication no.: 2001-256968, publication date 09/21/2001, 1 page	
/RA/	C2	Robert A. Huggins, "Lithium alloy negative electrodes formed from convertible oxides" Solid State Ionics, 113-115 (1998), p. 57-67	

EXAMINER /Raymond Alejandro/	DATE CONSIDERED 04/18/2007
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

INFORMATION DISCLOSURE CITATION <i>(Use several sheets if necessary)</i>				ATTY DOCKET NO. 04558/085001		APPLICATION NO. 10/810,505	
				Eri Kojima, et al.			
				FILING 03/26/2004		GROUP ART 1745	

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U.S. PATENT APPLICATION PUBLICATIONS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS								
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO

OTHER DOCUMENTS <i>(Including Author, Title, Date, Pertinent Pages, Etc.)</i>			
/RA/		C3	Noriyuki Tamura et al., "Study on the anode behavior of Sn and Sn-Cu alloy thin-film electrodes", Journal of Power Sources 107 (2002) p. 48-55
/RA/		C4	D. Larcher et al., "In Situ X-Ray Study of the Electrochemical Reaction of Li and n'-Cu6Sn5" Journal of The Electrochemical Society, 147 (2000) p. 1658-1662 5 pages

EXAMINER /Raymond Alejandro/	DATE CONSIDERED 04/18/2007
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Approved for use through 03/31/2007. OMB 0661-0031

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Substitute for form 1449/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(Use as many sheets as necessary)</i>				Complete if Known	
				Application Number	10/810,505-Conf. #8177
				Filing Date	March 26, 2004
				First Named Inventor	Eri KOJIMA
				Art Unit	1745
				Examiner Name	R. Alejandro
Sheet	1	of	1	Attorney Docket Number	5271-0113PUS1

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code ² (if known)	MM-DD-YYYY		
/RA/	AA*	US-2003/0180619-A1	09-25-2003	Tamura et al.	

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. ¹	Foreign Patent Document	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶
		Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	MM-DD-YYYY			
/RA/	BA	JP-2002-373647-A	12-26-2002			

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NON PATENT LITERATURE DOCUMENTS			
Examiner Initials	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²

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¹ Applicant's unique citation designation number (optional). ² Applicant is to place a check mark here if English language Translation is attached.

Examiner Signature	/Raymond Alejandro/	Date Considered	04/18/2007
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